# UNISONIC TECHNOLOGIES CO., LTD

# **UPG30N60**

### Insulated Gate Bipolar Transistor

## 600V, SMPS N-CHANNEL IGBT

### DESCRIPTION

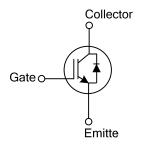
The UTC **UPG30N60** is a N-channel IGBT. it uses UTC's advanced technology to provide customers with high input impedance, high switching speed and low conduction loss, etc.

The UTC **UPG30N60** is suitable for high voltage switching, high frequency switch mode power supplies.

### ■ FEATURES

- \*  $V_{CE(SAT)} \le 2.3 V @ I_C=30A, V_{GE}=15V$
- \* 600V Switching SOA Capability
- \* High switching speed
- \* High input impedance
- \* Low conduction loss

### ■ SYMBOL

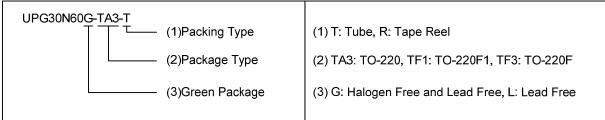


# TO-220F

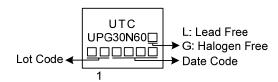
### ORDERING INFORMATION

Ordering Number		Dackage	Pin	Assignn	Dooking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
UPG30N60L-TA3-T	UPG30N60G-TA3-T	TO-220	G	С	E	Tube	
UPG30N60L-TF1-T	UPG30N60G-TF1-T	TO-220F1	G	С	E	Tube	
UPG30N60L-TF3-T	UPG30N60G-TF3-T	TO-220F	G	С	Е	Tube	

Note: Pin Assignment: G: Gate C: Collector E: Emitter



### **■** MARKING



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### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Collector-Emitter Voltage		V <sub>CES</sub>	600	V	
Gate to Emitter Voltage Continuous		$V_{GES}$	±20	V	
Continuous Collector Current	T <sub>C</sub> =25°C		60	Α	
	T <sub>C</sub> =100°C	- I <sub>C</sub>	30	Α	
Collector Current Pulsed (Note 2)		I <sub>CM</sub>	100	Α	
Single Pulse Avalanche Energy (Note 3)		E <sub>AS</sub>	66	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	7	V/ns	
	TO-220		125	W	
Power Dissipation	TO-220F	$P_{D}$	44.6	10/	
	TO-220F1		41.6	W	
Junction Temperature		TJ	-55 ~ <b>+</b> 150	°C	
Storage Temperature Range		T <sub>STG</sub>	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=5.0mH, PK<sub>IL</sub>=5.15A,  $V_{CC}$ =50V,  $R_G$ =25 $\Omega$ , Starting  $T_J$ =25 $^{\circ}$ C
- 4. I<sub>F</sub>≤8A, di/dt ≤200A/μs, V<sub>CC</sub>≤ BV<sub>CES</sub>, Starting T<sub>J</sub>=25°C

### **■ THERMAL CHARACTERISTICS**

PAR	AMETER	SYMBOL	RATINGS	UNIT
Junction to Case	TO-220		1	°C/W
	TO-220F TO-220F1	$\theta_{ m JC}$	3	°C/W

### ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
Collector-Emitter Breakdown Voltage	lector-Emitter Breakdown Voltage BV <sub>CES</sub> I <sub>C</sub> =250µA, V <sub>GE</sub> =0V			600			V	
Collector-Emitter Leakage Current					200	μΑ		
Collector Emitter Seturation Valtage	V <sub>CE(SAT)</sub>	1 -204 \/ -15\/	T <sub>J</sub> =25°C		1.9	2.3	V	
Collector-Emitter Saturation Voltage		I <sub>C</sub> =30A, V <sub>GE</sub> =15V	T <sub>J</sub> =125°C		2.2		V	
Gate to Emitter Threshold Voltage	$V_{GE(TH)}$	$I_C=250\mu A, V_{CE}=V_{GE}$		1.0		3.0	V	
Gate to Emitter Leakage Current I <sub>GES</sub> V <sub>CE</sub> =0V, V <sub>GE</sub> =20V					±400	nA		
Input Capacitance	CIES				520		pF	
utput Capacitance C <sub>OES</sub> V <sub>CE</sub> =30V, V <sub>GE</sub> =0V, f=1MHz				90		pF		
Reverse Transfer Capacitance	C <sub>RES</sub>				12		pF	
Total Gate Charge	$Q_G$				70		nC	
Gate-Emitter Charge	$Q_GE$	$I_C$ =15A, $V_{CE}$ =400V, $V_{GE}$		4.4		nC		
Gate-Collector Charge	$Q_{GC}$				12		nC	
Current Turn-On Delay Time	t <sub>D(ON)</sub>	$I_{C}$ =15A, $V_{CE}$ =400V, $V_{GE}$ =10V, $R_{G}$ =10 $\Omega$			8		ns	
Current Rise Time	t <sub>R</sub>				19		ns	
Current Turn-Off Delay Time	t <sub>D(OFF)</sub>				80		ns	
Current Fall Time	$t_{F}$			2500		ns		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Forward Voltage Drop	$V_{FM}$	I <sub>F</sub> =8A				2.4	V	
Reverse Recovery Time	t <sub>rr</sub>	-I <sub>F</sub> =8A, dI/dt=200A/μS			70		ns	
Reverse Recovery Charge	$Q_{rr}$				90		μC	

Note: Pulse Test: Pulse width  $\leq$  50 $\mu$ s.

### ■ TEST CIRCUIT AND WAVEFORMS

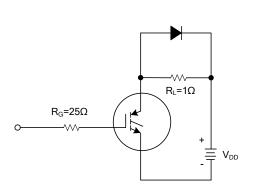


Fig 1. INDUCTIVE SWITCHING TEST CIRCUIT

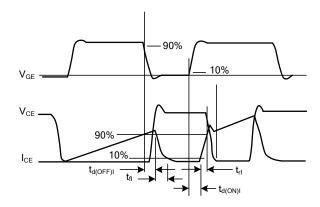
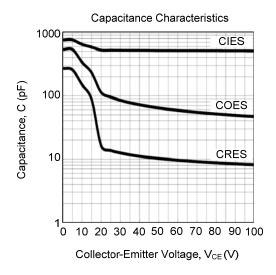
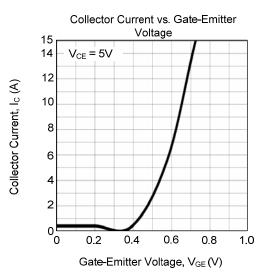
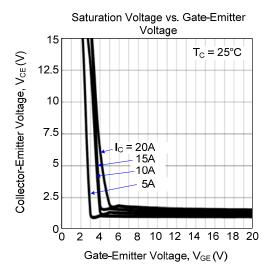


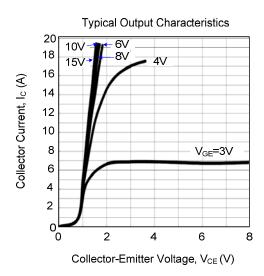
Fig 2. SWITCHING TEST WAVEFORMS

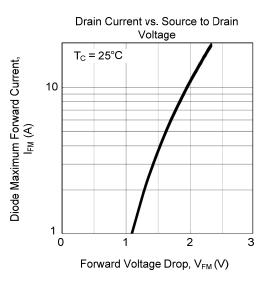
### **■ TYPICAL CHARACTERISTICS**

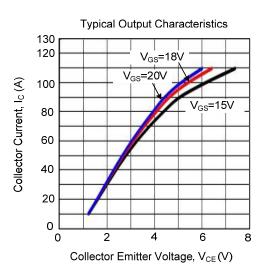












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